

# H11AV1M, H11AV1AM, H11AV2M, H11AV2AM Phototransistor Optocouplers

# Features

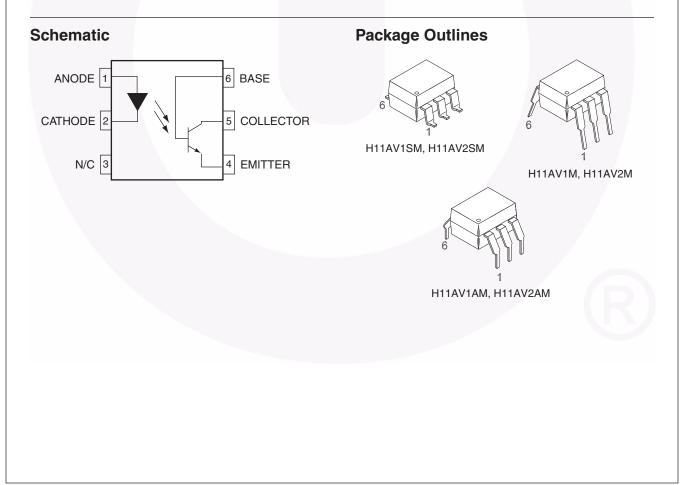
- H11AV1M and H11AV2M feature 0.3" input-output lead spacing
- H11AV1AM and H11AV2AM feature 0.4" input-output lead spacing
- UL recognized (File #E90700, Vol. 2)
- VDE recognized (File #102497)
- Add option V (e.g., H11AV1AVM)

## Applications

- Power supply regulators
- Digital logic inputs
- Microprocessor inputs

# Description

The general purpose optocouplers consist of a gallium arsenide infrared emitting diode driving a silicon phototransistor in a 6-pin dual in-line white package.



**Absolute Maximum Ratings** (T<sub>A</sub> = 25°C unless otherwise specified.) Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Value	Units
TOTAL DEV	ICE		
T <sub>STG</sub>	Storage Temperature	-40 to +150	°C
T <sub>OPR</sub>	Operating Temperature	-40 to +100	°C
T <sub>SOL</sub>	Wave Solder Temperature (see page 8 for reflow solder profiles)	260 for 10 sec	°C
PD	Total Device Power Dissipation @ T <sub>A</sub> = 25°C	250	mW
	Derate above 25°C	2.94	mW/°C
EMITTER			1
١ <sub>F</sub>	DC / Average Forward Input Current	60	mA
V <sub>R</sub>	Reverse Input Voltage	6	V
PD	LED Power Dissipation @ T <sub>A</sub> = 25°C	120	mW
	Derate above 25°C	1.41	mW/°C
DETECTOR			
V <sub>CEO</sub>	Collector-Emitter Voltage	70	V
V <sub>CBO</sub>	Collector-Base Voltage	70	V
V <sub>ECO</sub>	Emitter-Collector Voltage	7	V
PD	Detector Power Dissipation @ T <sub>A</sub> = 25°C	150	mW
	Derate above 25°C	1.76	mW/°C

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# Electrical Characteristics (T<sub>A</sub> = 25°C unless otherwise specified.)

### **Individual Component Characteristics**

Symbol	Parameter	Test Conditions	Min.	Тур.*	Max.	Unit
EMITTER	1		1			
V <sub>F</sub>	Input Forward Voltage (I <sub>F</sub> = 10mA)	T <sub>A</sub> = 25°C	0.8	1.18	1.5	V
		T <sub>A</sub> = -55°C	0.9	1.28	1.7	
		T <sub>A</sub> = 100°C	0.7	1.05	1.4	
I <sub>R</sub>	Reverse Leakage Current	V <sub>R</sub> = 6.0V			10	μA
DETECTOR			1			
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage	I <sub>C</sub> = 1.0mA, I <sub>F</sub> = 0	70	100		V
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	I <sub>C</sub> = 100μA, I <sub>F</sub> = 0	70	120		V
BV <sub>ECO</sub>	Emitter-Collector Breakdown Voltage	I <sub>E</sub> = 100μA, I <sub>F</sub> = 0	7	10		V
I <sub>CEO</sub>	Collector-Emitter Dark Current	V <sub>CE</sub> = 10V, I <sub>F</sub> = 0		1	50	nA
I <sub>CBO</sub>	Collector-Base Dark Current	V <sub>CB</sub> = 10V		0.5		nA
C <sub>CE</sub>	Capacitance	V <sub>CE</sub> = 0V, f = 1MHz		8		pF

### **Transfer Characteristics**

Symbol	Parameter	Test Conditions	Device	Min.	Тур.*	Max.	Unit
DC CHAR	ACTERISTIC		1			•	
CTR	Current Transfer Ratio, Collector to Emitter	I <sub>F</sub> = 10mA, V <sub>CE</sub> = 10V	H11AV1M H11AV1AM	100		300	%
			H11AV2M H11AV2AM	50			
V <sub>CE (SAT)</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 2mA, I <sub>F</sub> = 20mA	All			0.4	V
AC CHARA	ACTERISTIC		1			•	
T <sub>ON</sub>	Non-Saturated Turn-on Time	$I_{C} = 2mA, V_{CC} = 10V,$ $R_{L} = 100\Omega$ (Fig. 11)	All			15	μs
T <sub>ON</sub>	Non Saturated Turn-off Time	$I_{C} = 2mA, V_{CC} = 10V,$ $R_{L} = 100\Omega$ (Fig. 11)	All			15	μs

### **Isolation Characteristics**

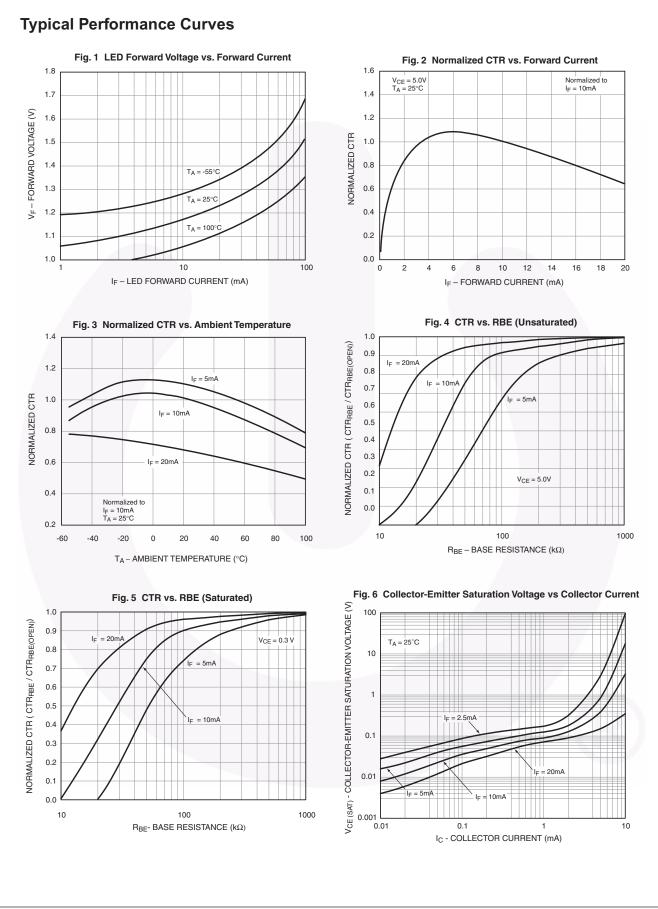
Symbol	Parameters	Test Conditions	Min.	Тур.*	Max.	Units
V <sub>ISO</sub>	Input-Output Isolation Voltage	f = 60Hz, t = 1 sec.	7500			V <sub>AC(pk)</sub>
C <sub>ISO</sub>	Isolation Capacitance	V <sub>I-O</sub> = 0V, f = 1MHz		0.2	2	pF
R <sub>ISO</sub>	Isolation Resistance	V <sub>I-O</sub> = 500 VDC	10 <sup>11</sup>			Ω

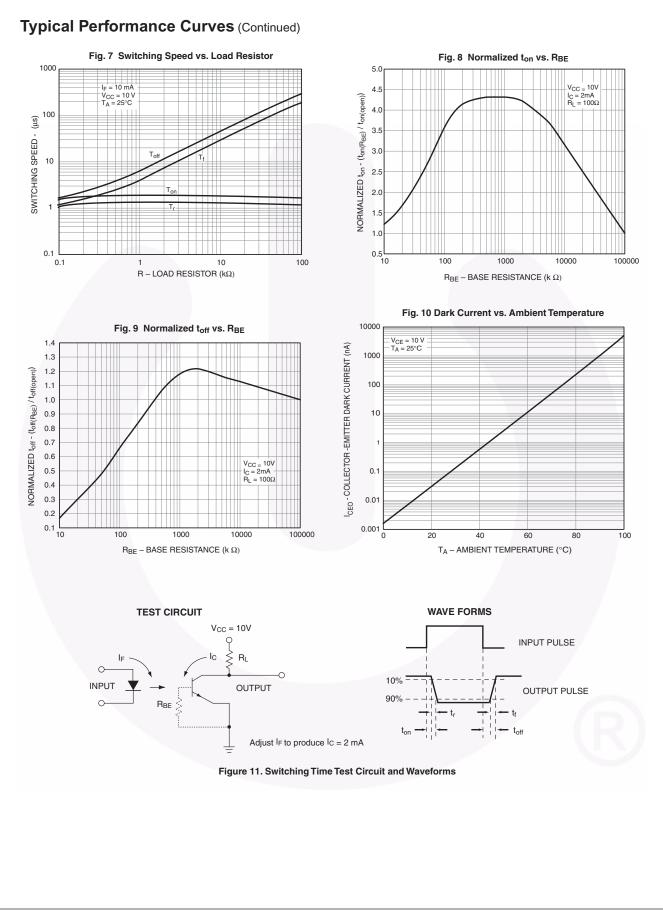
\*Typical values at  $T_A = 25^{\circ}C$ 

# Safety and Insulation Ratings

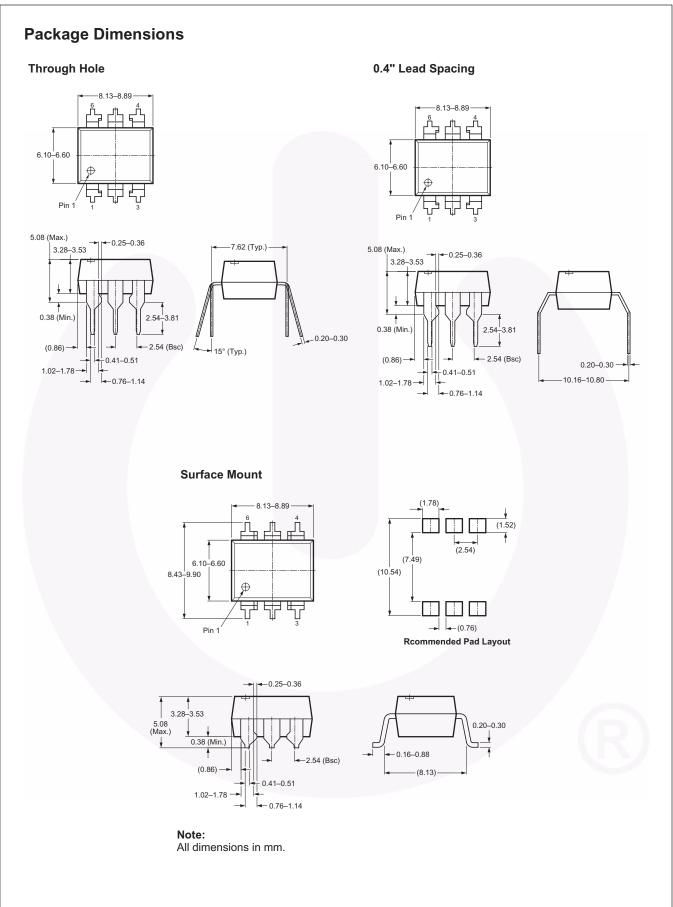
As per IEC 60747-5-2, this optocoupler is suitable for "safe electrical insulation" only within the safety limit data. Compliance with the safety ratings shall be ensured by means of protective circuits.

Symbol	Parameter	Min.	Тур.	Max.	Unit
	Installation Classifications per DIN VDE 0110/1.89 Table 1				
	For Rated Main Voltage < 150Vrms		I-IV		
	For Rated Main voltage < 300Vrms		I-IV		
	Climatic Classification		55/100/21		
	Pollution Degree (DIN VDE 0110/1.89)		2		
CTI	Comparative Tracking Index	175			
V <sub>PR</sub>	Input to Output Test Voltage, Method b, $V_{IORM} \times 1.875 = V_{PR}$ , 100% Production Test with tm = 1 sec, Partial Discharge < 5pC	1594			V <sub>peak</sub>
	Input to Output Test Voltage, Method a, $V_{IORM} \times 1.5 = V_{PR}$ , Type and Sample Test with tm = 60 sec, Partial Discharge < 5pC	1275			V <sub>peak</sub>
V <sub>IORM</sub>	Max. Working Insulation Voltage	850			V <sub>peak</sub>
V <sub>IOTM</sub>	Highest Allowable Over Voltage	6000			V <sub>peak</sub>
	External Creepage	7			mm
	External Clearance	7			mm
	Insulation Thickness	0.5			mm
RIO	Insulation Resistance at Ts, $V_{IO}$ = 500V	10 <sup>9</sup>	1		Ω





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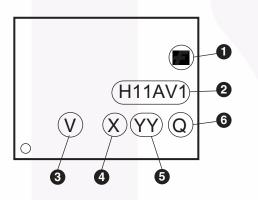


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# **Ordering Information**

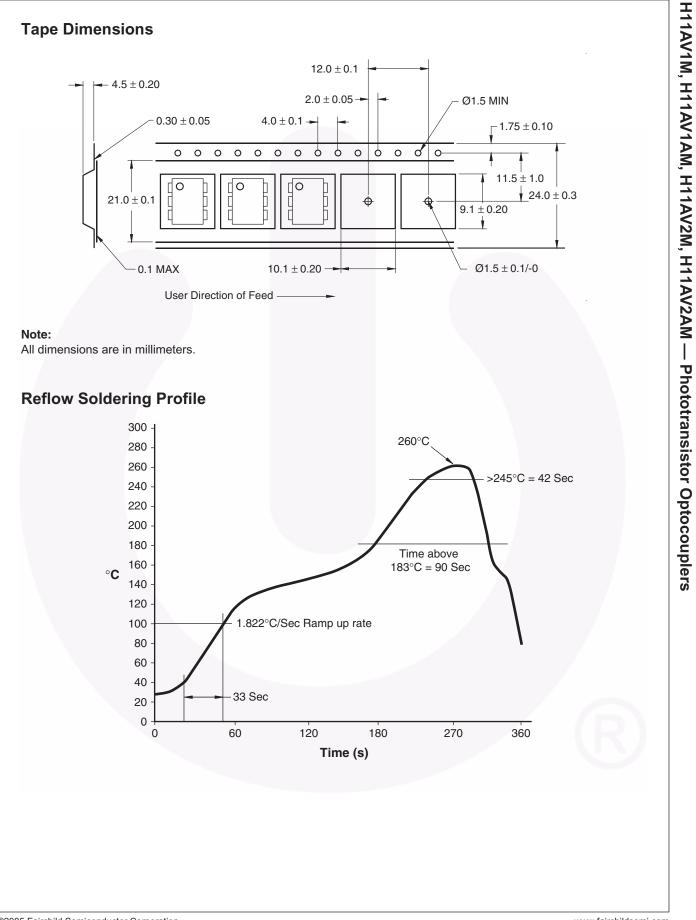
Option	Order Entry Identifier (Example)	Description
No option	H11AV1M	Standard Through Hole Device
S	H11AV1SM	Surface Mount Lead Bend
SR2	H11AV1SR2M	Surface Mount; Tape and Reel
Т	H11AV1TM	0.4" Lead Spacing
V	H11AV1VM	VDE 0884
TV	H11AV1TVM	VDE 0884, 0.4" Lead Spacing
SV	H11AV1SVM	VDE 0884, Surface Mount
SR2V	H11AV1SR2VM	VDE 0884, Surface Mount, Tape and Reel

# **Marking Information**



Definitions				
1	Fairchild logo			
2	Device number			
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table)			
4	One digit year code, e.g., '3'			
5	Two digit work week ranging from '01' to '53'			
6	Assembly package code			

\*Note – Parts that do not have the 'V' option (see definition 3 above) that are marked with date code '325' or earlier are marked in portrait format.





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